

Designation: E2737 – 10

## Standard Practice for Digital Detector Array Performance Evaluation and Long-Term Stability<sup>1</sup>

This standard is issued under the fixed designation E2737; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon ( $\varepsilon$ ) indicates an editorial change since the last revision or reapproval.

#### 1. Scope

1.1 This practice describes the evaluation of DDA systems for industrial radiology. It is intended to ensure that the evaluation of image quality, as far as this is influenced by the DDA system, meets the needs of users, and their customers, and enables process control and long term stability of the DDA system.

1.2 This practice specifies the fundamental parameters of Digital Detector Array (DDA) systems to be measured to determine baseline performance, and to track the long term stability of the DDA system.

1.3 The DDA system performance tests specified in this practice shall be completed upon acceptance of the system from the manufacturer and at intervals specified in this practice to monitor long term stability of the system. The intent of these tests is to monitor the system performance for degradation and to identify when an action needs to be taken when the system degrades by a certain level.

1.4 The use of the gages provided in this standard is mandatory for each test. In the event these tests or gages are not sufficient, the user, in coordination with the cognizant engineering organization (CEO) may develop additional or modified tests, test objects, gages, or image quality indicators to evaluate the DDA system. Acceptance levels for these ALTERNATE tests shall be determined by agreement between the user, CEO and manufacturer.

1.5 This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.

#### 2. Referenced Documents

- 2.1 ASTM Standards:<sup>2</sup>
- E1025 Practice for Design, Manufacture, and Material Grouping Classification of Hole-Type Image Quality Indicators (IQI) Used for Radiology
- E1316 Terminology for Nondestructive Examinations
- E1742 Practice for Radiographic Examination
- E2002 Practice for Determining Total Image Unsharpness in Radiology

E2445 Practice for Performance Evaluation and Long-Term Stability of Computed Radiography Systems

E2597 Practice for Manufacturing Characterization of Digital Detector Arrays

- E2698 Practice for Radiological Examination Using Digital Detector Arrays
- E2736 Guide for Digital Detector Array Radiology

#### 3. Terminology

3.1 *Definitions*—the definition of terms relating to gamma and X-radiology, which appear in Terminology E1316, Practice E2597, Guide E2736, and Practice E2698 shall apply to the terms used in this practice. bacdla/astm-e2737-10

3.2 Definitions of Terms Specific to This Standard:

3.2.1 *digital detector array (DDA) system*—an electronic device that converts ionizing or penetrating radiation into a discrete array of analog signals which are subsequently digitized and transferred to a computer for display as a digital image corresponding to the radiologic energy pattern imparted upon the input region of the device. The conversion of the ionizing or penetrating radiation into an electronic signal may transpire by first converting the ionizing or penetrating radiation into use of a scintillating material.

<sup>&</sup>lt;sup>1</sup> This practice is under the jurisdiction of ASTM Committee E07 on Nondestructive Testing and is the direct responsibility of Subcommittee E07.01 on Radiology (X and Gamma) Method.

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<sup>&</sup>lt;sup>2</sup> For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

These devices can range in speed from many seconds per image to many images per second, up to and in excess of real-time radioscopy rates (usually 30 frames per seconds).

3.2.2 *active DDA area*—the active pixelized region of the DDA, which is recommended by the manufacturer as usable.

3.2.3 *signal-to-noise ratio (SNR)*—quotient of mean value of the intensity (signal) and standard deviation of the intensity (noise). The SNR depends on the radiation dose and the DDA system properties.

3.2.4 *contrast-to-noise ratio (CNR)*—quotient of the difference of the signal levels between two material thicknesses, and standard deviation of the intensity (noise) of the base material. The CNR depends on the radiation dose and the DDA system properties.

3.2.5 *contrast sensitivity*—recognized contrast percentage of the material to examine. It depends on 1/CNR.

3.2.6 *spatial resolution (SR)*—the spatial resolution indicates the smallest geometrical detail, which can be resolved using the DDA with given geometrical magnification. It is the half of the value of the detector unsharpness divided by the magnification factor of the geometrical setup and is similar to the effective pixel size.

3.2.7 *material thickness range (MTR)*—the wall thickness range within one image of a DDA, whereby the thinner wall thickness does not saturate the DDA and at the thicker wall thickness, the signal is significantly higher than the noise.

3.2.8 frame rate-number of frames acquired per second.

3.2.9 *lag*—residual signal in the DDA that occurs shortly after detector read-out and erasure.

3.2.10 *burn-in*—change in gain of the scintillator that persists well beyond the exposure.

3.2.11 *bad pixel*—a pixel identified with a performance outside of the specification range for a pixel of a DDA as defined in Practice E2597.

3.2.12 *five-groove wedge*—a continuous wedge with five long grooves on one side (see Fig. 1).

3.2.13 *phantom*—a part or item being used to quantify DDA characterization metrics.

3.2.14 *duplex plate phantom*—two plates of the same material; Plate 2 has same size in x- and half the size in v- direction of Plate 1; the thickness of Plate 1 matches the minimum thickness of the material for inspection; the thickness of Plate 1 plus Plate 2 matches the maximum thickness of the material for inspection (see Fig. 2).

3.2.15 *DDA offset image*—image of the DDA in the absence of x-rays providing the background signal of all pixels.

3.2.16 *DDA gain image*—image obtained with no structured object in the x-ray beam to calibrate pixel response in a DDA.

3.2.17 *calibration*—correction applied for the offset signal and the non-uniformity of response of any or all of the X-ray beam, scintillator, and the read out structure.

3.2.18 *gray value*—the numeric value of a pixel in the DDA image. This is typically interchangeable with the term pixel value, detector response, Analog-to-Digital unit and detector signal.

3.2.19 *saturation gray value*—the maximum possible usable gray value of the DDA after offset correction.

Note 1—Saturation may occur because of a saturation of the pixel itself, the amplifier, or digitizer, where the DDA encounters saturation gray values as a function of increasing exposure levels.

3.2.20 *user*—the user and operating organization of the DDA system.

3.2.21 *customer*—the company, government agency, or other authority responsible for the design, or end user, of the system or component for which radiologic examination is required, also known as the CEO. In some industries, the customer is frequently referred to as the "Prime".

3.2.22 *manufacturer*—DDA system manufacturer, supplier for the user of the DDA system.

#### 4. Significance and Use

4.1 This practice is intended to be used by the NDT using organization to measure the baseline performance of the DDA and to monitor its performance throughout its service as an NDT imaging system.

4.2 It is to be understood that the DDA has already been selected and purchased by the user from a manufacturer based on the inspection needs at hand. This practice is not intended to be used as an "acceptance test" of the DDA, but rather to establish a performance baseline that will enable periodic performance tracking while in-service.

4.3 Although many of the properties listed in this standard have similar metrics to those found in Practice E2597, data collection methods are not identical, and comparisons among values acquired with each standard should not be made.

4.4 This practice defines the tests to be performed and required intervals. Also defined are the methods of tabulating results that DDA users will complete following initial baselining of the DDA system. These tests will also be performed periodically at the stated required intervals to evaluate the DDA system to determine if the system remains within acceptable operational limits as established in this practice or defined between user and customer (CEO).

4.5 There are several factors that affect the quality of a DDA image including the spatial resolution, geometrical unsharpness, scatter, signal to noise ratio, contrast sensitivity (contrast/noise ratio), image lag, and burn in. There are several additional factors and settings (for example, integration time, detector parameters or imaging software), which affect these results. Additionally, calibration techniques may also have an impact on the quality of the image. This practice delineates tests for each of the properties listed herein and establishes standard techniques for assuring repeatability throughout the lifecycle testing of the DDA.

#### 5. General Testing Procedures

5.1 The tests performed herein can be completed either by the use of the five-groove wedge phantom (see Fig. 1) or with separate IQIs on the Duplex Plate Phantom (see Fig. 2).

5.2 *DDA Calibration Method*—Prior to testing, the DDA shall be calibrated for offset and, or gain to generate corrected

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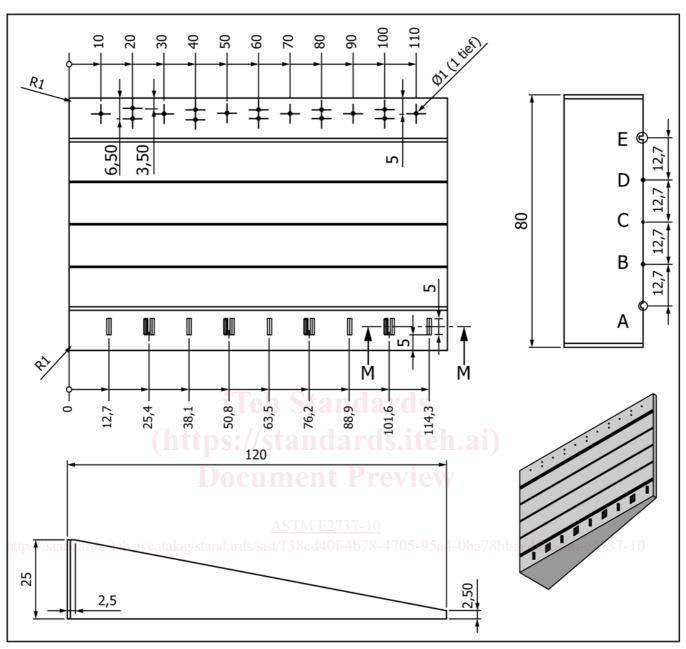


FIG. 1 5-Groove-Wedge (steel) - see Appendix

images per manufacturer's recommendation. It is important that the calibration procedure be completed as would be done in production during routine calibration procedures, and that these same procedures be used throughout the periodic testing of the DDA after it is in-service.

5.3 *Bad Pixel Standardization for DDAs*—Images collected for testing shall be corrected for bad pixels as would be done in production during routine bad pixel correction procedures per manufacturer's recommendation wherever required. A standardized nomenclature is presented in Practice E2597. The identification and correction of bad pixels in a delivered DDA remain in the purview of agreement between the user and the system manufacturer. The various tests shall be completed

under similar conditions as in production. Some parameters to control are listed below. If several different energies are used in production, the complete settings with the highest energy level shall be used for these tests.

- 5.3.1 X-ray tube voltage [kV]
- 5.3.2 tube current [mA]
- 5.3.3 focus detector distance (FDD) [mm]
- 5.3.4 object detector distance (ODD) [mm]
- 5.3.5 total exposure time per image [ms]

5.3.6 detector corrections (calibration and bad pixel substitution)

5.3.7 detector settings

5.3.8 image acquisition software and image processing

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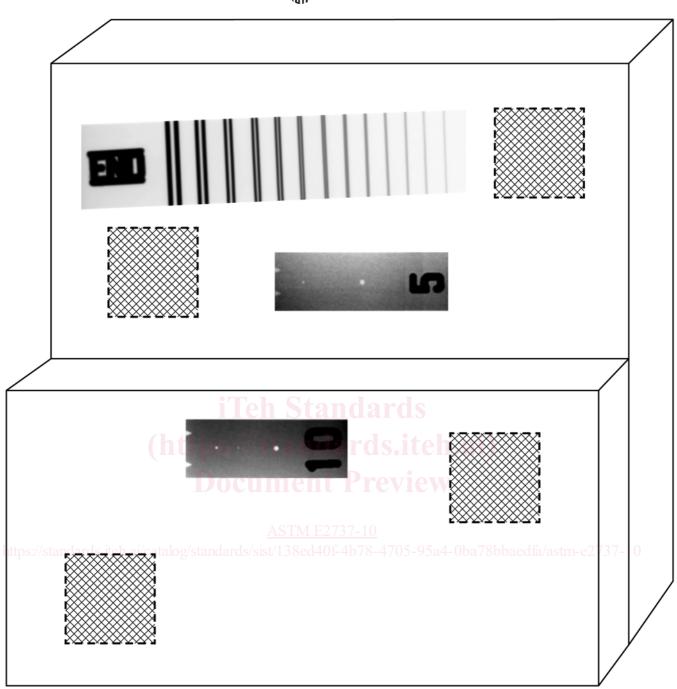


FIG. 2 Duplex Plate Phantom with IQIs positioned; one ASTM E1025 or E1742 Penetrameter on each plate and one ASTM E2002 Duplex Wire IQI on the thinner plate. The boxes ROI 1 to ROI 4 are for evaluation of signal level and SNR.

### 6. Application of Baseline Tests and Test Methods

#### 6.1 DDA System Baseline Performance Tests

6.1.1 The user shall accept the DDA system based on manufacturer's results of Practice E2597 on the specific detector as provided in a data sheet for that serialized DDA or other agreed to acceptance test between the user and manufacturer (not covered in this practice). The user baselines the DDA using the tests defined in Table 1. Additional tests are to be defined in agreement between the CEO and the using organi-

zation in terms of the specific tests to perform, how the data is presented, and the frequency of testing. This approach does the following:

6.1.1.1 Provides a quantitative baseline of performance,

6.1.1.2 provides results in a defined form that can be reviewed by the CEO and

6.1.1.3 offers a means to perform process checking of performance on a continuing basis.

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System Performance			System Perform	Process Check						
Parameter	Unit	Base Line	Software Update	Tube Change	Detector Change/ Repair	Short Version	Long Version	of	Duplex Plate Phantom	
Spatial Resolution	SR	μm	х		х	х	х	х	x	х
Contrast Sensitivity	CS	%	х	х	х	х	x	х	x	х
Material Thickness Range	MTR	mm	х	х	х	х	x	х	x	х
Signal to Noise Ratio	SNR		х	х	х	х	х	х	x	х
Signal Level	SL		х	х		х	х	х	x	х
Image Lag	Lag	%	х			х		х		
Burn In	BI	%	х			х		х	x	х
Offset Level	OL		х	х	х	х		х		
Bad Pixel Distribution			x	х	х	х	х	х		

#### TABLE 1 System Performance Tests and Process Check of the DDA System

6.1.2 Acceptance values, and tolerances thereof obtained from these tests shall also be in agreement between the CEO and the using organization.

6.1.3 Acceptance levels for individual bad pixels, bad clusters, relevant bad clusters, and bad lines, and their statistical distribution within the DDA, as well as proximity to said anomalies is to be determined by agreement between the user and the CEO. The user and or CEO may refer to the Guide for DDAs (E2736), Practice E2597, as well as consult with the manufacturer on how the prevalence of these anomalous pixels might impact a specific application. This practice does not set limits, but does offer a means for tracking such anomalous pixels in the table templates provided herein.

6.1.4 Given that the other elements of the DDA system are within their tolerances including the x-ray source/generator, the imaging system, and the inspection itself (for example errors with gain/offset mapping are controlled, as is any severe x-ray scatter in the inspection), and the test produces a result below the "agreed to" requirements, the detector is not to be placed in service unless it is repaired, replaced, or some other change is instituted that will assure the quality of the inspection as stated in the agreement between contracting parties.

6.1.5 The results of the initial test of the new system shall be documented, as delineated in Table 2 and Table 3 and taken as reference values "Result (new)" for further use.

6.1.6 Maximum deviations from Result (new) as tolerances and limits defined between contracting parties shall also be documented in Table 2 and Table 3 as reference values "Limit" for further use.

6.1.7 If a replacement DDA is placed into service, the reference values from the acceptance test shall be updated, and a new baseline formed.

6.2 User Tests After Repair, Hardware- or Software Upgrade—After modifications, such as repair or upgrade of the DDA system hardware, specialized tests are required to prove the proper performance of the DDA system with the new conditions. With a new DDA the reference values from the acceptance test shall be updated, too. Changes of the functionality of the system (for example, by new software version), which influence the image quality, also need a test to prove the proper performance of the system after changes.

6.3 User Tests for Long-Term Stability—Quality assurance requires periodic tests of the DDA system to ensure the proper

performance of the system. The time interval depends on the degree of usage of the system and shall be defined by the user with consideration of the DDA system manufacturer's information. There may be two versions of the long version stability tests, the complete program and a short version. The intervals for the performance checks shall not exceed ten days. The check for bad pixel shall be done daily. Details shall be agreed upon between the customer and the user.

### 7. Apparatus

7.1 The tests described in Table 1 and in Section 6 require the usage of either the five-groove wedge (see Fig. 1); or the Duplex Plate Phantom with separate IQIs—E2002 Duplex Wire and proper E1025 or E1742 penetrameters (see Fig. 2). However, this document does not preclude the use of other gauges or phantoms which can measure the same parameters listed in Table 1. The use of alternate gauges must be approved by the CEO.

7.1.1 The five-groove wedge shall be made from light metal as aluminum or heavy metal as stainless steel—selected based on the metal used in the application. Material and size can be taken from Appendix X1.

7.1.2 Duplex Plate Phantom—Two flat plates of the same material are used – either constructed from Aluminum (Material Group 02), Titanium (Material Group 01) or Stainless Steel (Material Group 1) – as needed to match the metal used in the application. The second plate covers half of the first plate (see Fig. 2). The thickness of the first plate is similar to the thinnest material thickness of the object in inspection, the thickness of both plate together is similar to the highest material thickness.

7.1.2.1 Application Procedures for DDA system Quality Indicators—The DDA system quality indicators provide an evaluation of the quality of a DDA system as well as for periodic quality control. Arrangement of the DDA system quality indicators shall be in accordance with this practice, or as specified by the CEO.

7.1.2.2 The E2002 Duplex Wire Gauge is placed on the thinner area as shown in Fig. 2. Two E1025 or E1742 penetrameters are placed on the plates, one on each plate of either the E1025 or the E1742, but not mixed, each adequate to the required contrast sensitivity (1-1T up to 4-4T). The four marked areas (*ROI 1 to ROI 4*) shall be left uncovered (see Fig. 2).

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#### TABLE 2 Test Report of DDA SystemReport of Bad Pixels and Clusters

DDA System					kV		energy				
Construction Year						mA		tube current			
Last Service								pre filter (material and thickness)			
Detector Settings								mm	focus detector distance		
Software					mm		mm	object detector distance			
Software Version							s	total exposure time per image			
Used IQI		5 Hole Wedge						Duple	lex Plate Phantom (separate IQIs)		
Test:	Acceptance Test										
		Test afte	after Repair or new Software								
	Longterm Stability (short version)										
		Longterm Stability (long version)									
Tests		Unit	Result (new) Lir		mit Result		cult				
			thin	thick	thin	thick	thin	thick	Remark		
Spatial Resolution SR		μm	um	THER		unck	<u>u</u> mi				
Contrast Sensitivity* CS											
Material Thickness Range MTR											
Signal to Noise Ratio SNR											
Signal Level SL											
Image Lag 1f Lag											
Burn In 1 / 10 min BI		%			4		1				
Offset Level OL						1018	][()	IS			
Bad Pixel Distribution			OK OK								
Date of Tests	(https://standards.iteh.ai)										
Conclusion	onclusion Document Proview										
Operator											

\* Two columns only needed when using Duplex Plate Phantom 727

https://standards.iteh.ai/catalog/standards/sist/138ed40f-4b78-4705-95a4-0ba78bbaedfa/astm-e2737-10

#### 8. Test Procedures

8.1 The tests listed in this section shall be performed with the listed phantom and corresponding IQIs at specified intervals as established in this practice and/or between the user of the DDA and the CEO. The radiation parameters of the performed tests, the date and operator name shall be included in all documentation.

8.1.1 Core Image Quality Tests:

8.1.1.1 Spatial resolution (by five-groove wedge or duplex plate phantom and duplex-wire method),

8.1.1.2 Contrast sensitivity (by five-groove wedge or duplex plate phantom with separate IQIs),

8.1.1.3 Signal to Noise Ratio (by five-groove wedge or duplex plate phantom with separate IQIs),

8.1.1.4 Signal level (by five-groove wedge or duplex plate phantom with separate IQIs),

8.1.1.5 Bad Pixel distribution (any relevant cluster shall be noted and Bad Pixel Map stored).

8.1.2 In applications with a larger material thickness range, for example for castings, the maximum material thickness range within one image for inspection shall be measured and included in the list above (see 8.1.1).

8.1.2.1 Material Thickness Range (by five-groove wedge or duplex plate phantom).

8.1.3 Image Lag and Burn In shall be measured at user/CEO defined intervals to test the temporal behavior of the DDA system for residual images following an exposure.

8.1.3.1 Image lag (no test object required).

8.1.3.2 Burn-in (by the five-groove wedge or the duplex plate phantom)

8.1.4 Degradation of the DDA may reduce the system sensitivity after extensive usage. For this reason, the DDA system shall be checked for increasing offset value at user-defined intervals.

8.1.4.1 Offset value (DDA response with no DDA corrections and without radiation).

8.2 *Procedure*—For the tests involving the phantoms of this practice, either the five-groove wedge or the duplex plate phantom shall be placed in the beam at the position which is designed for the test object with same focal spot detector distance (FDD) and object detector distance (ODD). X-ray settings (kV, mA, and focal spot) shall be the same as in the application.